Developing Cryotron Switches for TES Array Multiplexing

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Limitations in Both Current and Future Applications

- Next-generation TES arrays will require 10⁵ to 10⁶ pixels
- Improve imaging resolution
- Reduce measurement time
- Expand source capability
- Improvements on existing

Solution: The Cryotron



Control Current Actuation

- Maximum supercurrent I_{sig} versus control line current I_{con} at 70 mK
- Cryotron exhibits low-field regime with linear slope
- Meissner state
- High-field regime with long decaying tail

Ongoing Speed Testing



multiplexing strategies are needed

- Reduce # of wirebond pads
- Minimize power dissipation
- Reduce # of leads to mK stage



Binary Addressing

- # of pixels = $2^{(# of bond pads)}$
 - Significantly reduce bond pad area for large arrays
 - Compatible with time division multiplexing (TDM) & Φ-CDM

Single Cryotron

Buck, Dudley A. "The Cryotron-a superconductive computer component." Proceedings of the IRE 44, no. 4 (1956): 482-493.

- Proposed by Dudley Buck in 1950's
- Superconducting switch
 - Control line creates a magnetic field
- Signal line switches from superconducting to normal

Initial Cryotron Design

Lowell, P. J., et al. "A thin-film cryotron suitable for use as an ultra-low-temperature switch." Applied Physics Letters 109 (2016): 142601.



- Presence of vortices
- Required magnetic field is order of magnitude larger than predicted
- Non-uniform magnetic field
- Thin-film effects in AlMn



Switching Speed

- Cryotron in parallel circuit with SQUID
- Current is shunted to input coil
- Time constant $\tau \sim 30$ ns
- Measurement restricted by

- Implement dipole gradiometer
 - Minimize sensitivity to external magnetic fields
- Optimize gate design
 - Increase I_{signal}/ decrease I_{control}
 - Increase open state resistance
- Incorporate shunt resistor on chip
 - Reduce circuit inductance and "ringing" during switching
- Microwave SQUID readout

Requires in-plane switching

Current Steered-CDM

Irwin, K. D., et al. "Advanced code-division multiplexers for superconducting detector arrays." Journal of Low Temperature Physics 167.5-6 (2012): 588-594.



- Current steered code division multiplexing (I-CDM)
- No power dissipation in shunts

- Demonstrated with AlMn gate
- Transformer used to minimize control line current
 - 20-turn primary coil
 - Secondary coil in close proximity to signal line
- PECVD oxide used as insulator between Nb/AlMn layers

Cryotron Switching Field



readout electronics

- Switching speed < 200 ns
- Not limited by cryotron



Increasing Signal Line I_c and R

4-probe measurements of AlMn signal traces Critical current (I_c) and normal resistance (R)

Sensitive to tens of nanoseconds switching speed

Current Steering: Single-Pole, **Double-Throw**



- Ongoing work to demonstrate single-pole, double-throw switch
- Two cryotrons in parallel
- Current is steered to readout microwave SQUIDS
- Future applications

- Can integrate into focal plane
- Bolometers: long wavelengths arrays have room between pixels
- Calorimeters: overhanging absorbers demonstrated
- Issues to navigate
 - **TES bias variation**
 - Cross-talk
- **Requires in-plane switching**

Please see Malcolm Durkin's poster (PB-31)

- Maximum perpendicular magnetic field: $B_{\perp} = \frac{\mu_0 I_{con}}{8\pi d}$ Requires T_c of control line >> T_c of gate
- of AlMn can be tuned
- Simple model assumes current travels at edges of control line

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vs. trace geometry

Trace Width (μm)	2	2	6	6
# of Traces	1	6	1	2
Total Width (μm)	2	12	6	12
Normal Resistance (Ω)	113	20	30	15
Average Ic (µA)	15	313	199	290
I_c Standard Dev. (μ A)	1	42	14	32

- Binary addressing for TDM
- Coded readout in I-CDM
- Superconducting logic components

Conclusions and Future Work

• Cryotron demonstrated with switching speeds faster than 200 ns • Microfabrication compatible with calorimeter and bolometer arrays Pathway to reduce bond pad requirements for large arrays

— 5 μm

Continued Improvement

- Signal line material and geometry
- Reduce gate insulating thickness
- Minimize readout inductance
- Measure switching speed limit
- Demonstrate current-steering
- Implement binary addressing